

- Wide dynamic range 130 dB typ.
- Low noise level < -125 dBm
- Low trace noise 1 mdB rms
- High measurement speed 100µs/point
- High effective directivity > 45 dB
- Remote control LAN/GPIB/USB

T-Series high performance VNAs have a wide dynamic range, very low noise level and low trace noise. T-Series VNAs are widely used in microwave device measurement in wireless communication, broadcast, television devices, radar devices, semi-conductors and many more. T-Series Vector Network Analyzers are available as 2 port stand alone bench top or USB controlled analyzers, or multi port instruments, perfectly suited for R&D, Manufacturing, QA and Education.

Models

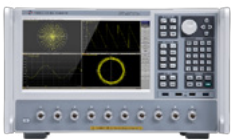
Model	Frequency Range	Type	Measurement Ports	System
T5230A	300 kHz to 3.0 GHz	Bench-top	2	Stand-alone
T5240A	300 kHz to 4.0 GHz	Bench-top	2	Stand-alone
T5260A	300 kHz to 6.0 GHz	Bench-top	2	Stand-alone
T5280A	300 kHz to 8.0 GHz	Bench-top	2	Stand-alone

RF & Microwave Technology

AWT-Global provides advanced telecommunication technology products and analyzers for a variety of RF and Microwave applications.

Related products

Multi port VNA



USB VNA



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Technical Specifications

Measurement Range	
Impedance	50 Ω , 75 Ω ¹
Test port connector	N-type (f)
Number of test ports	2
Frequency range:	
T5230A	300 kHz to 3.0 GHz
T5240A	300 kHz to 4.0 GHz
T5260A	300 kHz to 6.0 GHz
T5280A	300 kHz to 8.0 GHz
Full CW frequency accuracy	+/- 5 x 10 ⁻⁶
Frequency resolution	1 Hz
Measurement points	2 to 10001
Measurement bandwidths	1 Hz to 30 kHz (in 1/ 1.5/ 2/ 3/ 5/ 7 steps)
Dynamic range	>125 dB/130 dB typ. (IFBW = 30kHz)

¹With 50 Ω to 75 Ω pad

Measurement Accuracy	
Accuracy of transmission measurements (magnitude/phase)	
+5 to +15dB	0.2 dB / 2°
-50 to +5 dB	0.1 dB / 1°
-70 to -50 dB	0.2 dB / 2°
-90 to -70 dB	1.0 dB / 6°
Accuracy of reflection measurements (magnitude/phase)	
-15 to 0 dB	0.4 dB / 3°
-25 to -15 dB	1.0 dB / 6°
-35 to -25 dB	3.0 dB / 20°
Trace stability	
Trace noise magnitude	1 mdB rms (IFBW = 3 kHz)
Temperature dependence	0.02 dB
(per one degree of temperature variation)	

Test Port Output	
Match (w/o system error correction)	18 dB
Power range:	
300 kHz to 3.0 / / 4.0 / 6.0 GHz-60 dBm to +10 dBm	
6.0 GHz to 8.0 GHz	-60 dBm to +5 dBm
*System dependent	
Power accuracy	+/- 1.5 dB
Power resolution	0.05 dB

Test Port Input	
Match (w/o system error correction)	18 dB
Damage level	+26 dBm
Maximum DC voltage	+35 V
Noise level	< -125 dBm (IFBW = 30 kHz)

Effective System Data ¹	
Effective directivity	45 dB
Effective source match	40 dB
Effective load match	45 dB

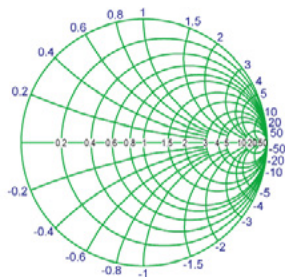
¹Applies over the temperature range of 23 °C +/- 5°C after 40 minutes of warming-up, with less than 1°C deviation from the full two-port calibration temperature, at output power of -5 dBm and IF bandwidth 10 Hz

Measurement Speed	
Measurement time per point	100 μ s
Source to receiver port switch overtime	<10 ms
Typical cycle times versus number of measurement points (IFBW = 30kHz)	51, 201, 401, 1601
Uncorrected (start 300 kHz, Stop 10MHz)	13.1, 51.3, 102.3, 408.3 (ms)
Full two-port calibration (start 300 kHz, stop 10 MHz)	45.5, 122.0, 230.5, 840.5 (ms)
Uncorrected (start 10 MHz, stop 8 GHz)	6.5, 21.1, 40.5, 157.7 (ms)
Full two-port calibration (start 10 MHz, stop 3,4,6 or 8 GHz)	32.4, 61.7, 100.3, 333.0 (ms)

General Data	
Display	10.4 inch TFT color LCD, touch screen
External Trigger input connector	BNC (f), input level range: 0 to +5V
External reference frequency	BNC (f), 10MHz, 2 dBm +/- 2 dB
VGA video output	15-pin mini D-sub; (f); driving the VGA compatible monitors
GPIB connector (optional)	24-pin D-sub (type D-24) (f); compatible with IEEE -488
USB connector	(f) provides connection to printer, ECal module, USB storage
LAN connector	10/100/1000 Base T Ethernet, 8-pin configuration
Operating temperature	+5° to +40°C
Storage temperature	-45° to +55°C
Humidity (max.)	90% (25°C)
Atmospheric pressure	84 to 106.7 kPa
Calibration Interval	3 years
Power Supply	220V (AC), +/- 10%
Power Consumption	60 W
Dimensions mm / in (W x H x D)	440 x 231 x 360 / 17.3 x 9.1 x 14.2
Weight	12.5 kg / 27.5 lbs

Technical Specifications

Measurement Capabilities	
Measure parameters	$S_{11}, S_{12}, S_{21}, S_{22}$
Measurement Channels	Up to 16 independent logical channels. Each logical channel is represented on the screen as an individual channel window. A logical channel is defined by such stimulus signal settings as frequency range, number of test points, power level, etc.
Data traces	Up to 16 data traces can be displayed in each channel window. A data trace represents one of such parameters of the DUT as S-parameters, response in time domain, input power response.
Memory traces	Each of the 16 data traces can be saved into memory for further comparison with the current values.
Data display formats	Logarithmic magnitude, linear magnitude, phase, expanded phase, group delay, SWR, real and imaginary parts, Smith chart diagram and polar diagram.



Smith Chart Format

Trace Functions	
Trace Display	Data trace, memory trace or simultaneous indication of data and memory traces.
Trace math	Data trace modification by math operations: addition, subtraction, multiplication or division, of measured complex values and memory data.
Autoscaling	Automatic selection of scale division and reference level value to have the trace most effectively displayed.
Electrical delay	Calibration plane moving to compensate for the delay in low-loss tests setup. Compensation for electrical delay in a DUT during measurements of deviation from linear phase.
Phase offset	Phase offset defined in degrees
Statistics	Calculation and display of mean, standard deviation and peak-to-peak deviation for a data trace.

Data Analysis	
Port impedance conversion	The function of conversion of the S-parameters measured at 50 Ω port into the values, which could be determined if measured at a test port with an arbitrary impedance.
De-embedding	The function allows to mathematically exclude from the measurements result the effect of the fixture circuit connected between the calibration plane and the DUT. This circuit should be described by an S-parameter matrix in a Touchstone file
Embedding	The function allows to mathematically simulate the DUT parameters after virtual integration of a fixture circuit between the calibration plane and the DUT. This circuit should be described by an S-parameter matrix in a Touchstone file.
S-parameter conversion	The function allows conversion of the measured S-parameters to the following parameter: reflection impedance and admittance, transmission impedance and admittance and inverse S-parameters.
Time domain transformation	The function performs data transformation from frequency domain into response of the DUT to various stimulus types in time domain. Modeled stimulus types: bandpass, lowpass impulse, and lowpass step. Time domain span is set by the user arbitrarily from zero to maximum, which is determined by the frequency step. Windows of various forms are used for better tradeoff between resolution and level of spurious sidelobes.
Time domain gating	The function mathematically removes unwanted response in time domain that allows for obtaining frequency response without influence from the fixture elements. The function applies reverse transformation
Limit Test	The limit test is a function to perform the pass/fail judgment based on the limit line you set in the limit table. In limit test, if the measured value is within the upper or lower limits indicated by the limit lines, the result is pass; if it is exceeded, the result is fail for all measurement points on the trace. Measurement points in the stimulus range with no limit lines are considered pass.
Ripple Test	The ripple test is a function for evaluating the results on a pass/fail basis based on the ripple limit, which is set using the ripple limit table. You can specify up to 12 frequency bands, which permits a test for each frequency band.

Technical Specifications

Accuracy Enhancement

Calibration Calibration of a test setup (which includes the Analyzer, cables and adapters) significantly increases the accuracy of measurements. Calibration allows for correction of the errors caused by imperfections in the measurement system: system directivity, source and load match, tracking and isolation.

Calibration methods The following calibration methods with various sophistication and accuracy enhancement level are available:

- reflection and transmission normalization
- full one-port calibration
- one-path two-port calibration
- full two-port calibration

Reflection and transmission Magnitude and phase correction of normalization frequency response errors for reflection or transmission measurements.

Full one-port calibration Magnitude and phase correction of frequency response, correction of directivity and source match errors for one-port reflection measurements.

One-path two-port calibration Calibration for reflection and one way transmission measurements. Similar to one-port calibration for reflection measurements. Magnitude and phase correction of frequency response and correction of source match errors for transmission measurements.

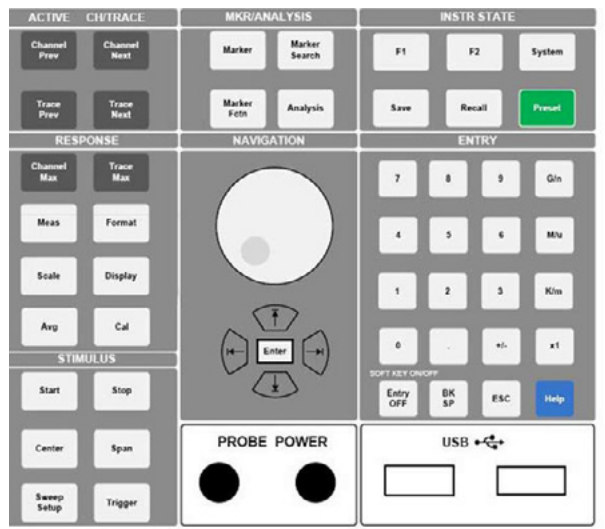
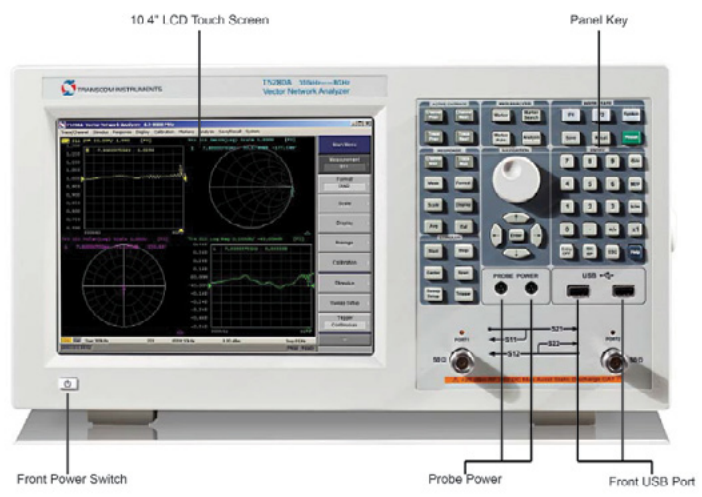
Full two-port calibration Calibration for full S-parameter matrix measurement of a DUT. Magnitude and phase correction of frequency response directivity, source match, load match and isolation. Isolation calibration can be omitted.

Directivity calibration (optional) Correction of directivity additional to the reflection normalization.

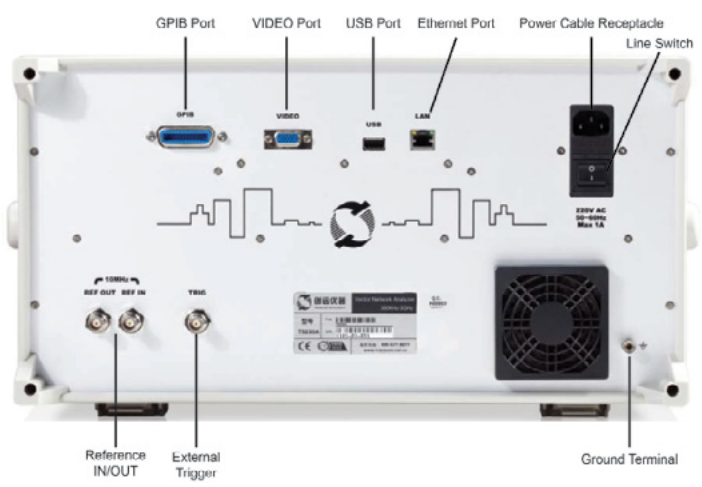
Isolation calibration (optional) Correction of isolation additional to the transmission normalization, one path two-port calibration or full two-port calibration.

Error correction interpolation When the user changes the settings such as start/stop frequencies and number of sweep points, which are different from the settings at the time of calibration interpolation or extrapolation of the calibration coefficients will be applied.

Front and Rear Panels, Screen



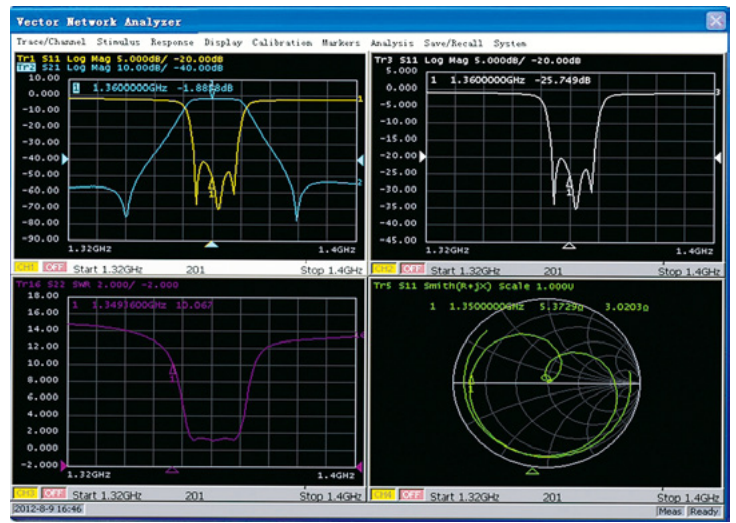
Front Panel Buttons



Technical Specifications

Marker Functions	
Data markers	Up to 16 markers for each trace. Reference marker available for delta marker operation. Smith chart diagram supports 5 marker formats: linear magnitude/phase, log magnitude/phase, real/imaginary, R + jX and G + jB Polar diagram supports 3 marker formats: linear magnitude/phase, log magnitude/phase, and real/imaginary.
Reference marker	Enables indication of any marker values as relative to the reference marker.
Marker search	Search for max, min, peak or target values on trace.
Marker search additional features	User-definable search range. A function for specific condition tracking or single operation search.
Setting parameters by markers	Setting of start, stop and center frequencies by the stimulus value of the marker and setting of reference level by the response value of the marker.
Marker math functions	Statistics, bandwidth
Statistics	Calculation and display of mean, standard deviation and peak-to-peak in a frequency range limited by two markers on a trace.
Bandwidth	Determines the bandwidth between cutoff frequency points of an active marker or absolute maximum. The bandwidth value, center frequency, upper and lower frequencies, Q value and insertion loss are displayed.

Sweep Features	
Measured points per sweep	Set by the user from 2 to 10001
Sweep type	Linear frequency sweep, logarithmic frequency sweep and segment frequency sweep, when the stimulus power is a fixed value, and linear power sweep when frequency is a fixed value.
Segment sweep features	A frequency sweep within several independent user-defined segments. Frequency range, number of sweep points, source power and IF Bandwidth should be set for each segment.
Power	Source power from -55 dBm to +10 dBm with resolution of 0.05 dB. In frequency sweep mode the power slope can be set up to 2 dB/GHz for compensation of high frequency attenuation in connection wires.
Sweep trigger	Trigger modes: continuous, single, hold Trigger sources: internal, manual, external



10.4" LCD Touch Screen

Order Information

Model	Description
T5230A	T-Series Vector Network Analyzer, 2 port, Frequency Range 300 kHz to 3.0 GHz, Bench-top, Dimensions 440 mm x 231 mm x 360 mm, Weight 12.5 kg
T5240A	T-Series Vector Network Analyzer, 2 port, Frequency Range 300 kHz to 4.0 GHz, Bench-top, Dimensions 440 mm x 231 mm x 360 mm, Weight 12.5 kg
T5260A	T-Series Vector Network Analyzer, 2 port, Frequency Range 300 kHz to 6.0 GHz, Bench-top, Dimensions 440 mm x 231 mm x 360 mm, Weight 12.5 kg
T5280A	T-Series Vector Network Analyzer, 2 port, Frequency Range 300 kHz to 8.0 GHz, Bench-top Dimensions 440 mm x 231 mm x 360 mm, Weight 12.5 kg
TVNA-PWR115	T series VNA Power supply for 110-120VAC / 60Hz

Accessories

Model	Description
TCAL6N	VNA Calibration Kit, DC-6 GHz, N-Connectors, 50 Ohms, SOL N(f), SOL N(m), THROUGH N(f)-N(f), THROUGH N(m)-N(m)
TCAL9N	VNA Calibration Kit, DC - 9 GHz, 50 Ohms, N-Connectors, SHORT N(f) & N(m), OPEN N(f) & N(m), LOAD N(f) & N(m), THROUGH N(f)-N(f) & N(m) - N(m)
TCAB-PN6N	Phase Noise Test Cable, DC-6GHz, 50 Ohms, 1m, N(m)-N(m), VSWR 1.1:1
TCAB-PN6NS	Phase Noise Test Cable, DC-6GHz, 50 Ohms, 1m, N(m)-SMA(m), VSWR 1.1:1
TCAB-PN18N	Phase Noise Test Cable, DC-18GHz, 50 Ohms, 1m, N(m)-N(m)
TCAB-PN18NS	Phase Noise Test Cable, DC-18GHz, 50 Ohms, 1m, N(m)-SMA(m)
T5-RM	Rack Mount Kit for T-Series VNAs
T5-FH	Front Handle Kit for T-Series VNAs



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